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LIST REFERENCES CITED BY APPLICANT  (Use several sheets if necessary)  Regine, et al.											
LIST REFERENCES CITED BY APPLICANT  (Use several sheets if necessary)  Peyne, et al.											
(Use several sheets if necessary) Peyne, et al.	· · · · · · · · · · · · · · · · · · ·										
	170	Payne, et al.									
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12/04/01 176	1762 2823										
U.S. PATENT DOCUMENTS											
"EXAMBRE DOCUMENT NUMBER DATE NAME CLASS SUI	RUBCLASS FI	ING DATE									
AA 5,783,495 07/21/98 Li, et al. 438 73	38 04	5/1996									
AB 5,780,406 07/14/98 Honda, et al. 510 17		26/1985									
AC 5,766,668 06/16/98 Brommelsiek, et al. 426 64	48 pat	2891 Pe									
	i										
FOREIGN PATENT DOCUMENTS											
DOCUMENT NUMBER DATE COUNTRY CLASS SUB											
	YES	NO.									
OTHER REFÉRENCES (Including Author, Title, Date, Pertinent Pages, Etc.)											
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EXAMINER Pulis P. Maldarado DATE CONSIDERED 10/19/2000											
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U.S. PATENT DOCUMENTS													
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE		RAME	CLASS	SUBCLASS	FILIN IF APPI	IG DATE ROPRIATE				
an	AA	5,209,858	05/1993	Heinshon et al.		252	1	62/6	१६/१९१				
June	АВ	5,554,320	09/1996	Yianakopoulos		252	389.23	O9/33					
pur	AC	5,560,857	10/1996	Sakon et al.		510	175	10/11	11994				
Jeur2	AD	5,739,579	04/1998	Chiang et al.		257	635	69(16	1996				
per	AE	5,817,572	10/1998	Chiang et al.	<u> </u>	438	624		11996				
Jun2	AF	5,877,075	03/1999	Dai et al.		438	597	10/14	11997				
tell	AG	5,891,799	04/1999	Tsui		438	624	Osti	8/1997				
<i>'</i>													
		·											
	FOREIGN PATENT DOCUMENTS												
		DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUBCLASS	TRANS	SLATION				
RIN)	АН	O 253 675 A1	01/1988	EPO		<del>                                     </del>	-	. AER	NO.				
run	Al	EP 0 773 480 A1	05/1997	EPO		$\vdash$							
Well !	LA	EP 0 875 926 A1	11/1998	EPO									
Jul	AK	WO 99/60083	11/1999	PCT									
0													
		OTHER RE	FERENCES Uncl	luding Author, Title	e, Date, Pertinent Pages, Etc.)								
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